

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	C	US-5,984,470	11-1999	Sakino et al.	347/106
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	L	US-			
	M	US-			

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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